



ACE1551B

N-Channel Enhancement Mode Field Effect Transistor

Description

The ACE1551B combines advanced trench MOSFET technology with a low resistance package to provide This device is ideal for Power Supply Converter Circuits and Load/Power Switching Cell Phones, Pagers.

Features

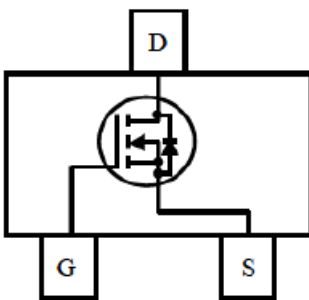
- $V_{DS} = 20V$
- $I_D = 0.7A$
- $R_{DS(ON)} < 360m\Omega$ ($V_{GS} = 4.5V$)
- $R_{DS(ON)} < 420m\Omega$ ($V_{GS} = 2.5V$)
- $R_{DS(ON)} < 560m\Omega$ ($V_{GS} = 1.8V$)

Absolute Maximum Ratings

Parameter	Symbol	Max	Unit	
Drain-Source Voltage	V_{DSS}	20	V	
Gate-Source Voltage	V_{GSS}	± 12	V	
Continuous Drain Current * AC	I_D	$T_A = 25^\circ C$	700	mA
		$T_A = 70^\circ C$	560	
Pulsed Drain Current * B	I_{DM}	1	A	
Power Dissipation	P_D	$T_A = 25^\circ C$	0.27	W
		$T_A = 70^\circ C$	0.16	
Operating Junction Temperature / Storage Temperature Range	T_J/T_{STG}	-55/150	$^\circ C$	

Packaging Type

SOT-723



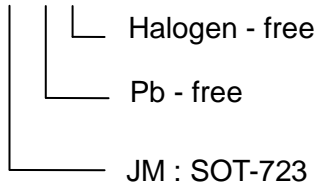


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Ordering information

ACE1551B XX + H



Electrical Characteristics

$T_A=25^{\circ}\text{C}$, unless otherwise specified.

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\ \mu A$	20			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_{DS}=250\ \mu A$	0.4		1.0	
Gate Leakage Current	I_{GSS}	$V_{DS}=0V, V_{GS}=\pm 12V$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=20V, V_{GS}=0V$			1	μA
Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=4.5V, I_D=0.8A$		300	360	m Ω
		$V_{GS}=2.5V, I_D=0.7A$		340	420	
		$V_{GS}=1.8V, I_D=0.6A$		420	560	
Forward Transconductance	g_{fs}	$V_{DS}=10V, I_D=0.4A$		1		S
Diode Forward Voltage	V_{SD}	$I_{SD}=0.15A, V_{GS}=0V$		0.65	1.2	V
Switching						
Total Gate Charge	Q_g	$V_{DS}=10V, V_{GS}=4.5V, I_D=0.6A$		1.06	1.38	nC
Gate-Source Charge	Q_{gs}			0.18		
Gate-Drain Charge	Q_{gd}			0.32		
Turn-On Time	$t_{d(on)}$	$V_{GS}=4.5V, I_D=0.5A, V_{DS}=10V, R_G=1\ \Omega$		18	26	nS
	t_r			20	28	
Turn-Off Time	$t_{d(off)}$			70	110	
	t_f			25	40	
Dynamic						
Input Capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=10V, f=1\text{MHz}$		70		pF
Output Capacitance	C_{oss}			20		
REVERSE Transfer Capacitance	C_{rss}			8		



Note:

1. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}C$. The value in any given application depends on the user's specific board design.
2. Repetitive rating, pulse width limited by junction temperature.
3. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient .
4. The static characteristics are obtained using $<300 \mu s$ pulses, duty cycle 0.5% max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}C$. The SOA curve provides a single pulse rating.

Typical Performance Characteristics

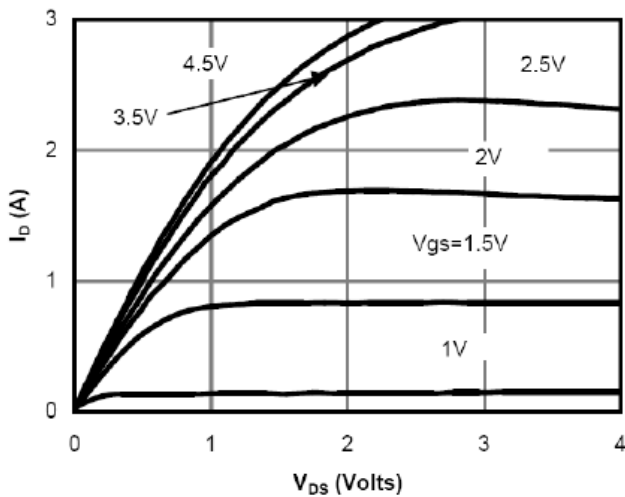


Figure 1: On-Region Characteristics

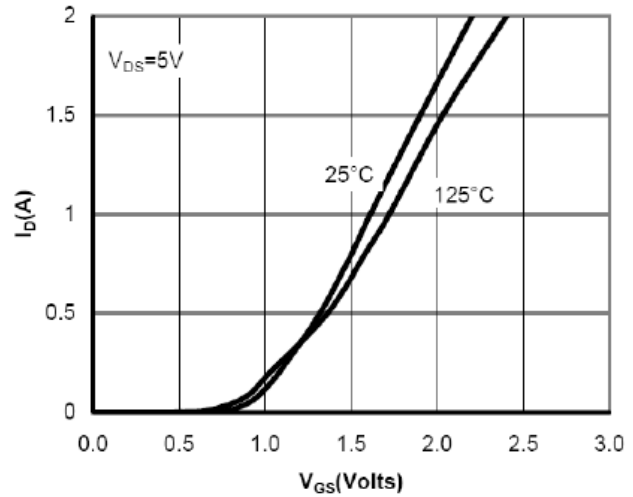


Figure 2: Transfer Characteristics

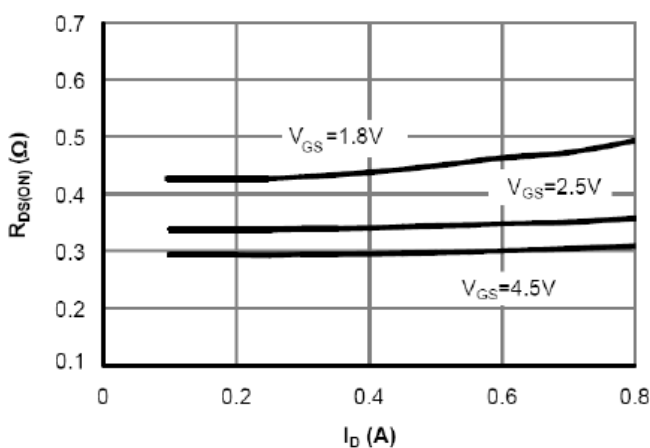


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

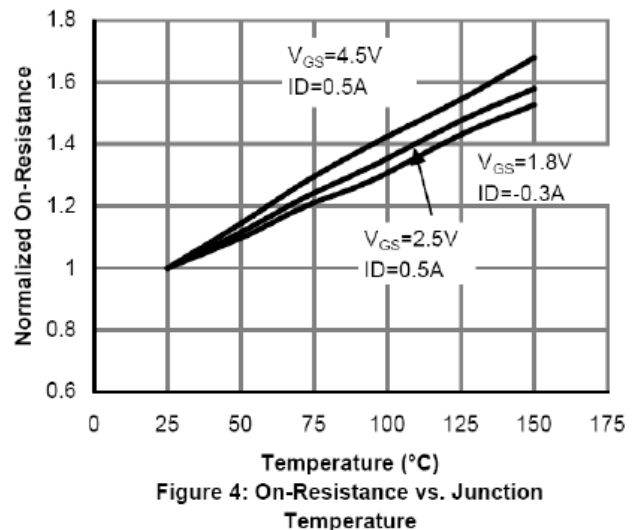


Figure 4: On-Resistance vs. Junction Temperature



Typical Performance Characteristics

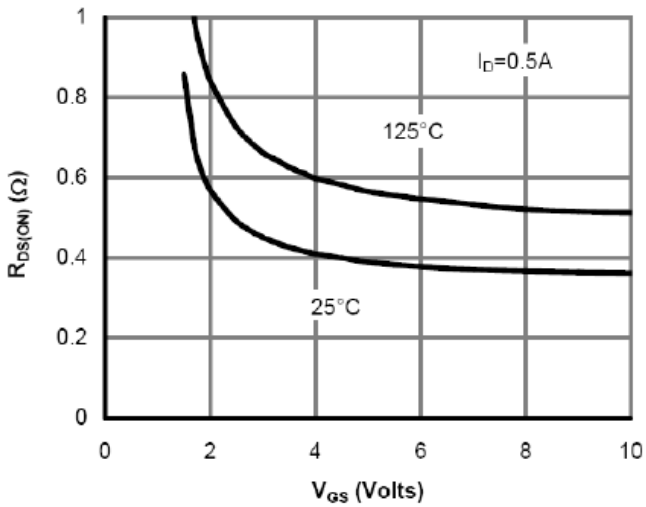


Figure 5: On-Resistance vs. Gate-Source Voltage

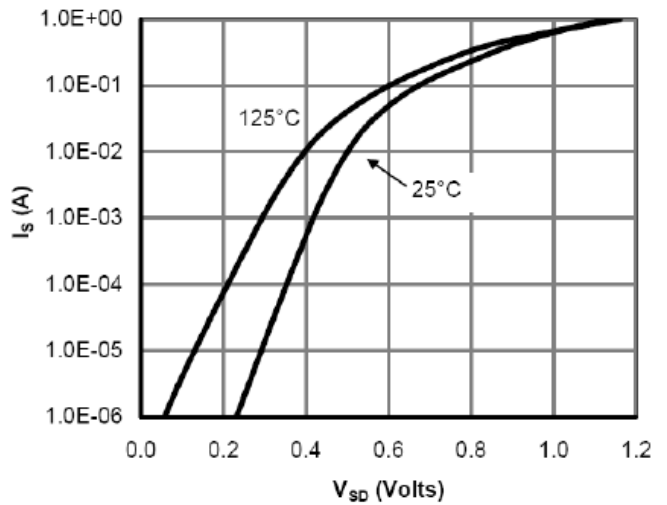


Figure 6: Body-Diode Characteristics

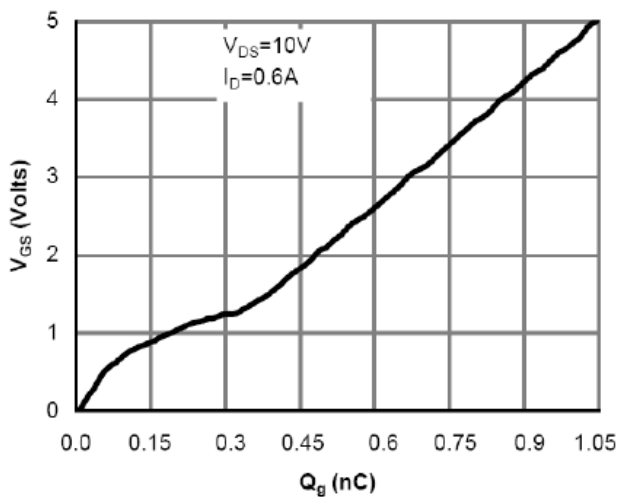


Figure 7: Gate-Charge Characteristics

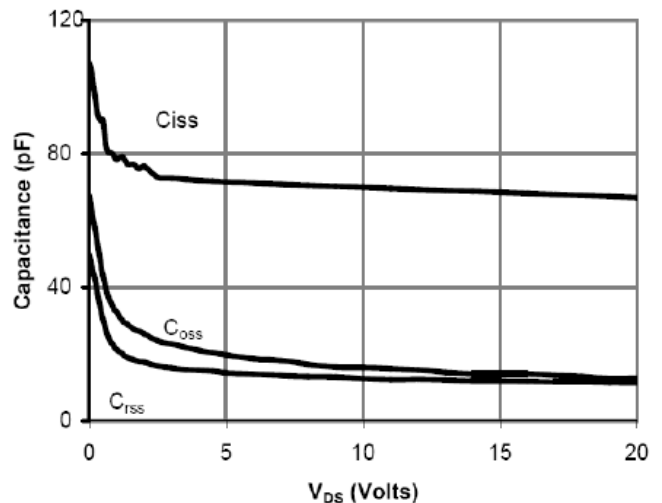


Figure 8: Capacitance Characteristics

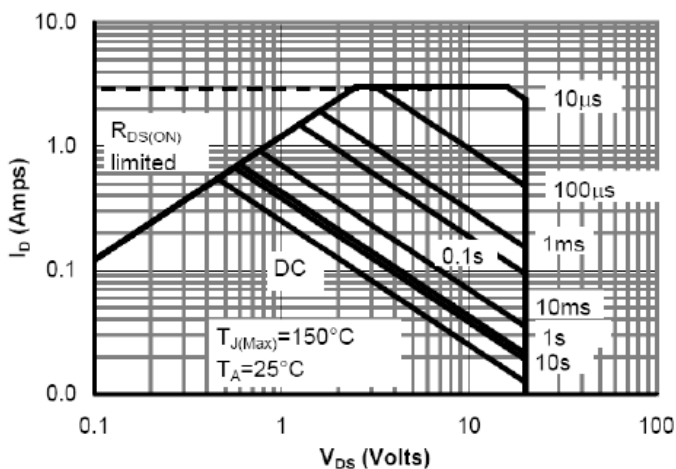


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

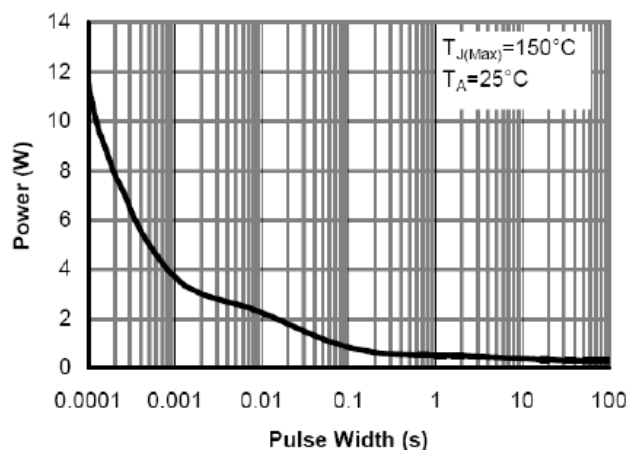


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)



Typical Performance Characteristics

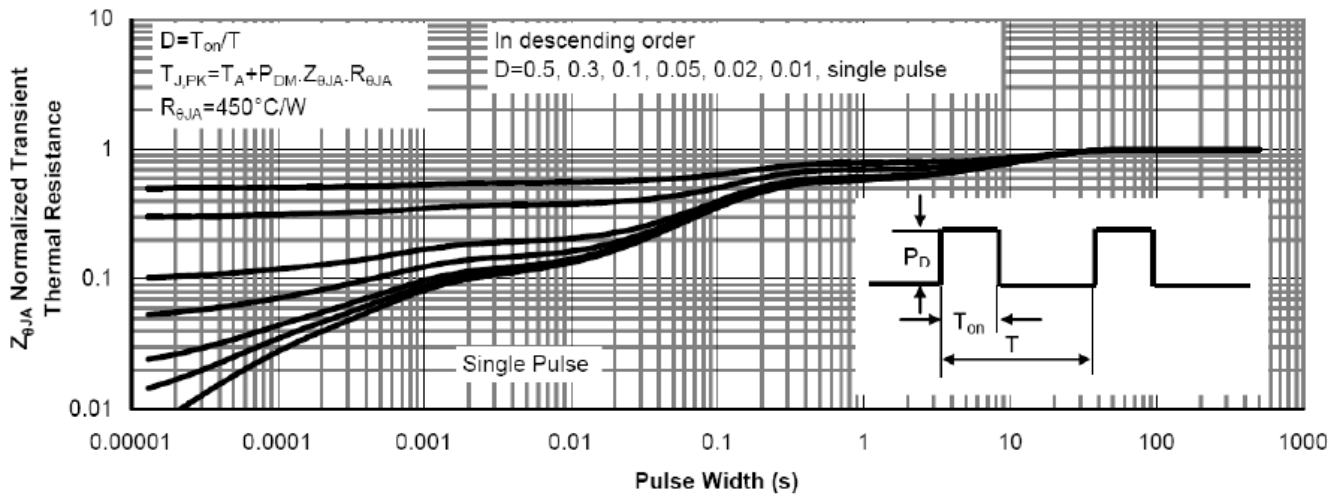


Figure 11: Normalized Maximum Transient Thermal Impedance

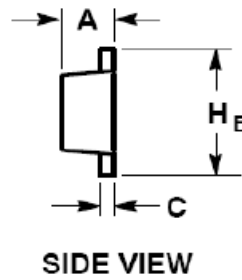
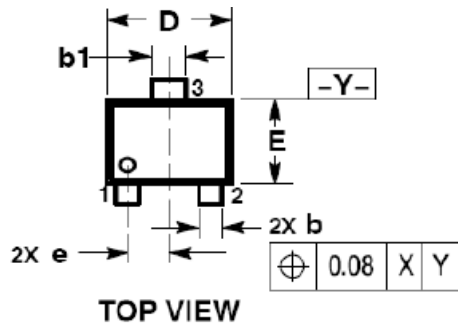


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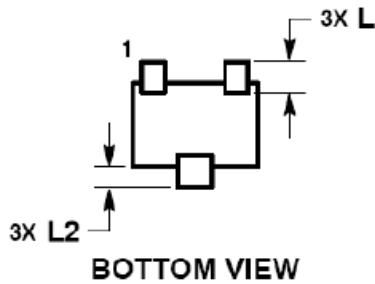
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Packing Information

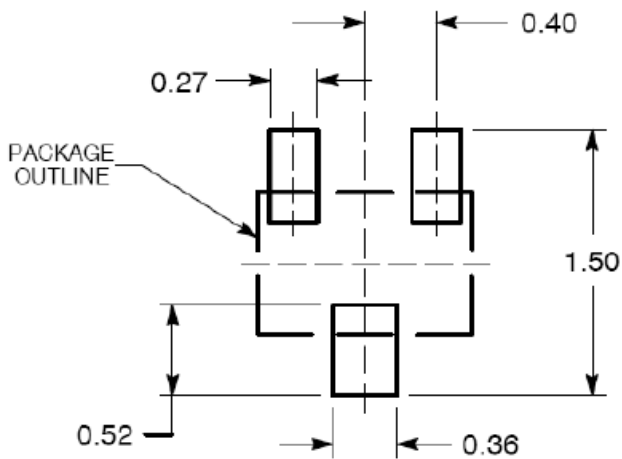
SOT-723



DIM	MILLIMETERS		
	MIN	NOM	MAX
A	0.45	0.50	0.55
b	0.15	0.21	0.27
b1	0.25	0.31	0.37
C	0.07	0.12	0.17
D	1.15	1.20	1.25
E	0.75	0.80	0.85
e	0.40 BSC		
H _E	1.15	1.20	1.25
L	0.29 REF		
L2	0.15	0.20	0.25



RECOMMENDED SOLDERING FOOTPRINT





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Notes

ACE does not assume any responsibility for use as critical components in life support devices or systems without the express written approval of the president and general counsel of ACE Electronics Co., LTD. As sued herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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